

<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>	
	10/649,169	AGAM ET AL.	
	<b>Examiner</b> April Y. Shan	<b>Art Unit</b> 2135	

**SEARCHED**

<b>INTERFERENCE SEARCHED</b>			
Class	Subclass	Date	Examiner